

KCB820

High Isolation SPDT
0.02 – 6 GHz



DESCRIPTION

KCB820 is a GaAs pHEMT Non-Reflective high performance, low loss switch in a 7 lead Hermetic Surface-Mount Technology (SMT) package for Harsh Environments including Defense and Satellite application. This device can be ordered with the 100% screening requirements of MIL-PRF-38535 Class B and S, in addition to the required QCI.

FEATURES

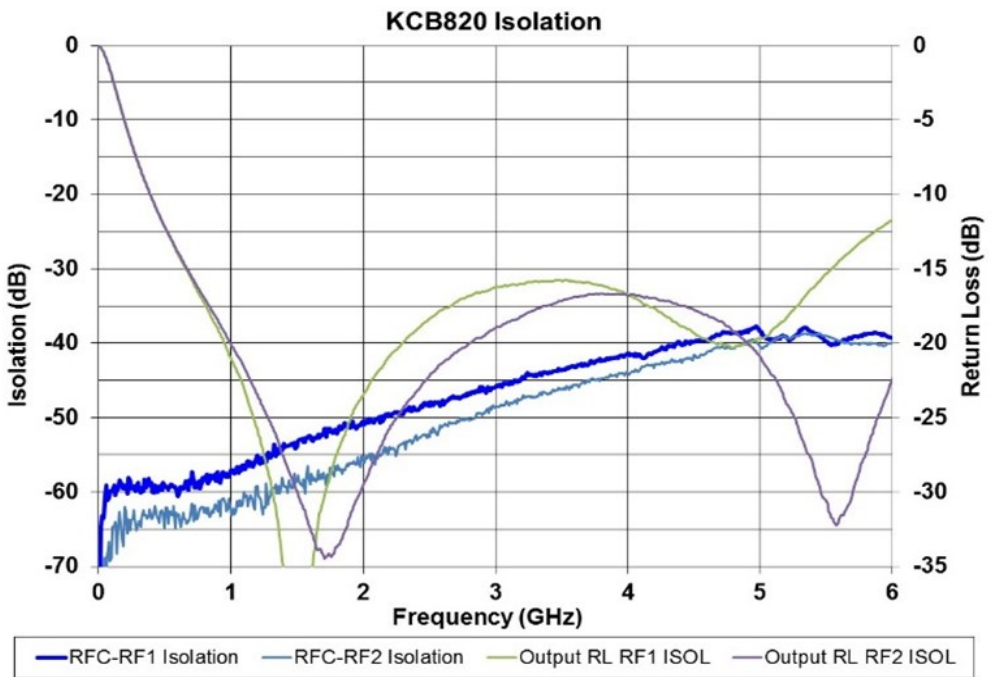
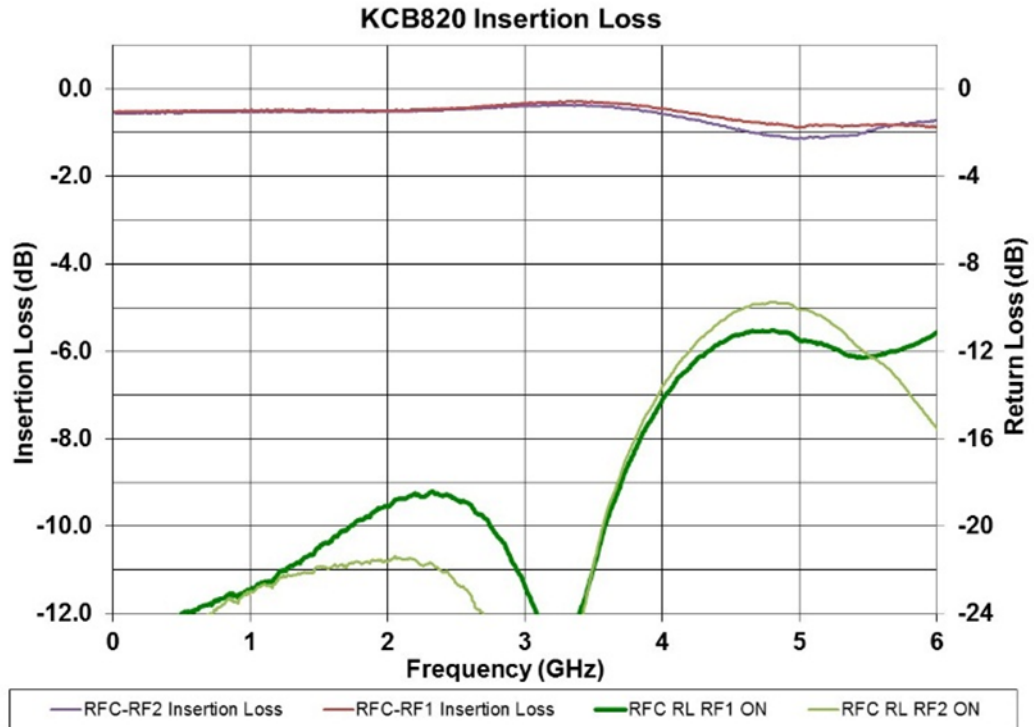


- ✓ **Low Loss: .8 dB @ 2 GHz Isolation: 55 dB @ 2 GHz.**
- ✓ **Non Reflective Match in off State (S22).**
- ✓ **NASA EEE-INST-002 compliant.**
- ✓ **Successfully Tested to 1M RAD TID.**
- ✓ **High Reliability Class B and S Screening Available.**
- ✓ **See Page 4 for MFR HI –REL Ordering Details.**

ELECTRICAL CHARACTERISTICS (+25°C)

Parameter	Conditions	Min	Typical	Max	Units
Insertion Loss	0.02 – 2.0 GHz		0.75	1.10	dB
	2.0 – 3.0 GHz		0.8	1.25	dB
	3.0 – 4.0 GHz		1.0	1.35	dB
	4.0 – 6.0 GHz		1.5	1.8	dB
RF1/RF2 Return Loss (ON-State)	0.02 – 2.0 GHz	19	22		dB
	2.0 – 3.0 GHz	15	22		dB
	3.0 – 4.0 GHz	12	18		dB
	4.0 – 6.0 GHz	9	12		dB
RF1/RF2 Return Loss (OFF-State)	0.02 – 0.1 GHz	0	0		dB
	0.1 – 0.5 GHz	5	8		dB
	0.5 – 2.0 GHz	9	11		dB
	2.0 – 3.0 GHz	12	15		dB
	3.0 – 4.0 GHz	12	15		dB
	4.0 – 6.0 GHz	9	13		dB
Isolation	0.02 – 2.0 GHz	50	55		dB
	2.0 – 3.0 GHz	50	55		dB
	3.0 – 4.0 GHz	40	50		dB
	4.0 – 6.0 GHz	35	45		dB
Input 1 dB Compression (P1dB)	Vctrl = 0V/+5V, 0.5- 2.0 GHz		+30		dBm
Third Order Output Intercept Point (IP3)	+8 dBm Input Tones, 1 MHz Spacing, Vctrl = 0V/5V, 0.5- 2.0 GHz		+46		dBm
Switching Speed: Rise, Fall ON/OFF	10/90% or 90/10% RF 50% CTL to 90/10% RF		5		nS
			15		nS
Negative (Positive) Control					
Vctrl High	DC Voltage	-7.0 (+2.7)	-5.0 (+5.0)	-4.5 (+7.0)	V
Vctrl Low	DC Voltage	-0.25	0	+0.25	V
I ctrl	DC Current		50	200	uA

TYPICAL PERFORMANCE (+25°C)



Note: Typical Insertion loss change .003db/degree C. .

TRUTH TABLE/NEGATIVE CONTROL

Control Input		Signal Path State	
B	A	RFC to RF1	RFC to RF2
-5.0	0	ON	OFF
0	-5	OFF	ON

TRUTH TABLE/POSITIVE CONTROL

Control Input		Signal Path State	
B	A	RFC to RF1	RFC to RF2
0	+5.0	ON	OFF
+5.0	0	OFF	ON

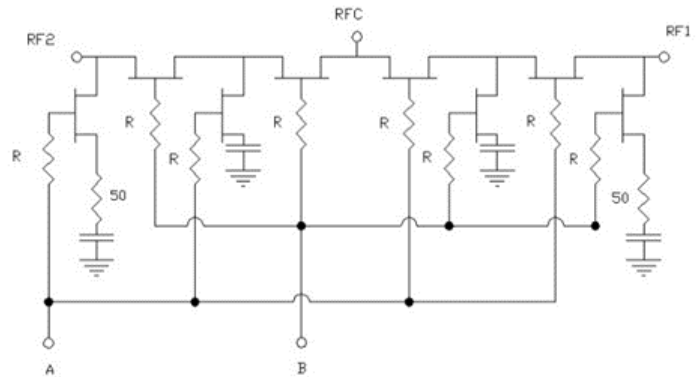
Note: External blocking capacitors are required on all RF ports for positive control operation. Capacitor should be selected to allow for low frequency operation.

ABSOLUTE MAXIMUM RATINGS

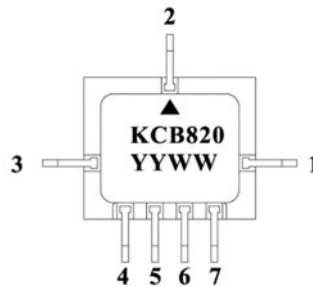
Exceeding Max limits may cause damage

Characteristic	Min.	Max.	Units
Control Voltage	-7.5	+7.5	Volts
RF Input Power		+30	dBm
Storage Temperature	-65	+150	°C
Operating Case Temp	-55	+125	°C
Junction Temperature		+150	°C
Operating Frequency	0.03	6.00	GHz

SCHEMATIC



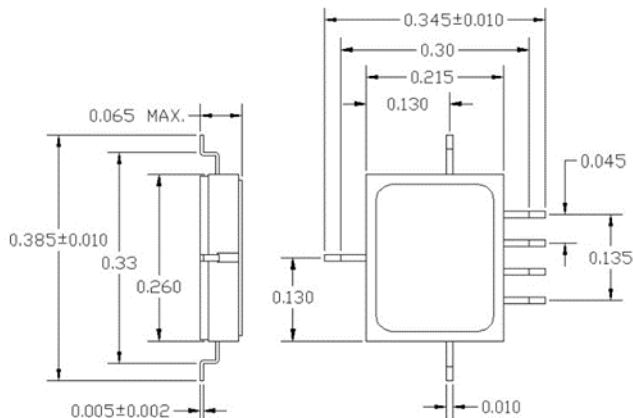
PINOUT



1	RF 2
2	RF C
3	RF 1
4	GND
5	A
6	B
7	GND

XXX = Serial number will be added for Class B and S Part numbers

OUTLINE DRAWING



Caution: Class Zero (HBM 200V) Electrostatic Sensitive Device. Proper ESD precaution should be used when handling device.

MFR HI-REL SCREENING FLOW

Test Inspection	MIL – STD -883		Requirement	
	Method	Condition	Class B	Class S
Wafer Lot Acceptance /1	5007		N/A	Per Wafer Lot
Non-Destructive Bond Pull	2023		SPC	SPC
Internal Visual	2010	A= Class S, B = Class B	100%	100%
Temperature Cycle	1010	C	100%	100%
Acceleration	2001	E (Y1 only)	100%	100%
PIND	2020	A (5 Cycles)	N/A	100%
Serialization	Per Product Specification		100%	100%
Radiographic	2012	2 views	N/A	100%
Electrical Test	Small Signal Testing	+25°C	100%	100%
Burn In	1015	A	100%/160 Hours/125°C	100%/320 Hours/125 °C
Final Electrical	Small Signal Testing	+25°C	100%	100%
PDA Calculation	5004	25% Δ IL / 100% Δ Icc	5%	5%/3% functional
Group A Electrical/5	Per Product Specification	-55°C + 125°C	45/0	45/0
Leak Test	1014 A and C	1 x 10 -8 Max	100%	100%
External Visual	2009		100%	100%

NOTES

1. Product under configuration control per KCB QAP 015.
2. Customer will be notified of all class 1 changes for Class B and S part numbers.
3. Wafer Lot Acceptance will include 100% die visual, SEM analysis and Lot Traceability.
4. Electrical Test Data will be recorded for each serial number and included in Final Test Report for all Class S part numbers.
5. Group A Electrical testing will include the Small Signal and I_c at the Min/Max operating condition. The Dynamic test (P1dB, IP3, SS) will be tested at +25c only.

ORDERING INFORMATION

	Unscreened	Class B	Class S
KCB Solutions Part Number	KCB820C	KCB820B	KCB820S

